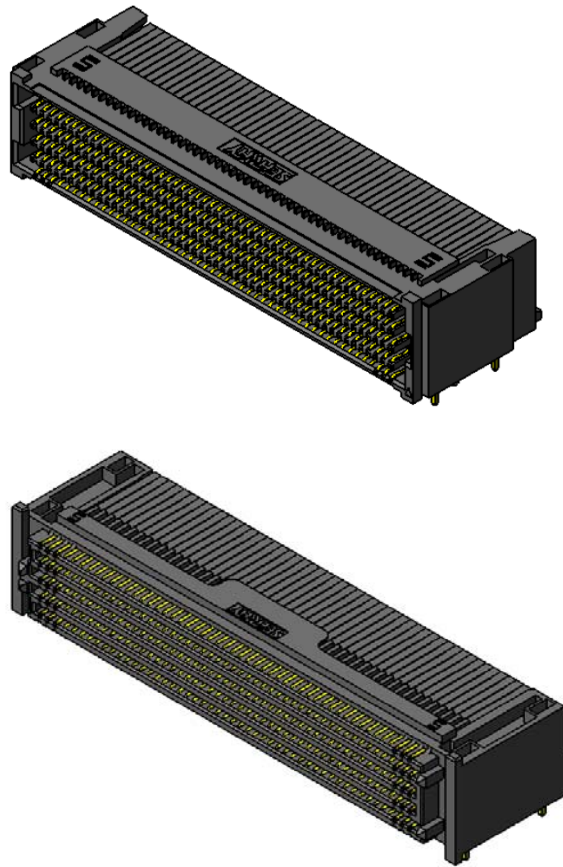




Project Number: Design Qualification Test Report	Tracking Code: 341424_Report_Rev_1
Requested by: Craig Ryan	Date: 12/15/2014
Part #: SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR	
Part description: SEAF/SEAM	Tech: Aaron McKim
Test Start: 8/19/2014	Test Completed: 12/5/2014



(Actual part not depicted)

DESIGN QUALIFICATION TEST REPORT
SEAF/SEAM
SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR

Tracking Code: 341424_Report_Rev_1	Part #: SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR
Part description: SEAF/SEAM	

REVISION HISTORY

DATA	REV.NUM.	DESCRIPTION	ENG
12/15/2014	1	Initial Issue	KH

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead Free
- 9) Samtec Test PCBs used: PCB-106450-TST/PCB-106451-TST/PCB-106452-TST

FLOWCHARTS

Gas Tight

Group 1

SEAF-50-01-L-10-2-RA-TR

SEAM-50-01-L-10-2-RA-TR

8 Assemblies

Step	Description
------	-------------

- | | |
|----|--|
| 1. | LLCR ⁽²⁾ |
| 2. | Gas Tight ⁽¹⁾ |
| 3. | LLCR ⁽²⁾
Max Delta = 15 mOhm |

(1) Gas Tight = EIA-364-36

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

Thermal Aging

Group 1

SEAF-50-01-L-10-2-RA-TR

SEAM-50-01-L-10-2-RA-TR

8 Assemblies

Step	Description
------	-------------

- | | |
|----|--|
| 1. | Contact Gaps |
| 2. | Mating/Unmating Force ⁽²⁾ |
| 3. | LLCR ⁽¹⁾ |
| 4. | Thermal Age ⁽³⁾ |
| 5. | LLCR ⁽¹⁾
Max Delta = 15 mOhm |
| 6. | Mating/Unmating Force ⁽²⁾ |
| 7. | Contact Gaps |

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mating/Unmating Force = EIA-364-13

(3) Thermal Age = EIA-364-17

Test Condition = 4 (105°C)

Time Condition = B (250 Hours)

FLOWCHARTS Continued**Mating/Unmating/Durability**Group 1

SEAF-50-01-L-10-2-RA-TR
SEAM-50-01-L-10-2-RA-TR
8 Assemblies

Step	Description
1.	Contact Gaps
2.	LLCR ⁽²⁾
3.	Mating/Unmating Force ⁽³⁾
4.	Cycles Quantity = 25 Cycles
5.	Mating/Unmating Force ⁽³⁾
6.	Cycles Quantity = 25 Cycles
7.	Mating/Unmating Force ⁽³⁾
8.	Cycles Quantity = 25 Cycles
9.	Mating/Unmating Force ⁽³⁾
10.	Cycles Quantity = 25 Cycles
11.	Mating/Unmating Force ⁽³⁾
12.	Contact Gaps
13.	LLCR ⁽²⁾ Max Delta = 15 mOhm
14.	Thermal Shock ⁽⁴⁾
15.	LLCR ⁽²⁾ Max Delta = 15 mOhm
16.	Humidity ⁽¹⁾
17.	LLCR ⁽²⁾ Max Delta = 15 mOhm
18.	Mating/Unmating Force ⁽³⁾

Group 2

SEAF-30-01-L-08-2-RA-TR
SEAM-30-01-L-08-2-RA-TR
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force ⁽³⁾
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force ⁽³⁾
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force ⁽³⁾
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force ⁽³⁾
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force ⁽³⁾

Group 3

SEAF-20-01-L-04-2-RA-TR
SEAM-20-01-L-04-2-RA-TR
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force ⁽³⁾
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force ⁽³⁾
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force ⁽³⁾
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force ⁽³⁾
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force ⁽³⁾

(1) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(3) Mating/Unmating Force = EIA-364-13

(4) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**IR/DWV****Pin-to-Pin**

Group 1		Group 2		Group 3		Group 4	
SEAF-50-01-L-10-2-RA-TR		SEAF-50-01-L-10-2-RA-TR		SEAM-50-01-L-10-2-RA-TR		SEAF-50-01-L-10-2-RA-TR	
SEAM-50-01-L-10-2-RA-TR				2 Assemblies		SEAM-50-01-L-10-2-RA-TR	
2 Assemblies		2 Assemblies		2 Assemblies		2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown ⁽²⁾	1.	DWV Breakdown ⁽²⁾	1.	DWV Breakdown ⁽²⁾	1.	IR ⁽⁴⁾
						2.	DWV at Test Voltage ⁽¹⁾
						3.	Thermal Shock ⁽⁵⁾
						4.	IR ⁽⁴⁾
						5.	DWV at Test Voltage ⁽¹⁾
						6.	Humidity ⁽³⁾
						7.	IR ⁽⁴⁾
						8.	DWV at Test Voltage ⁽¹⁾

Row-to-Row

Group 5		Group 6		Group 7		Group 8	
SEAF-50-01-L-10-2-RA-TR		SEAF-50-01-L-10-2-RA-TR		SEAM-50-01-L-10-2-RA-TR		SEAF-50-01-L-10-2-RA-TR	
SEAM-50-01-L-10-2-RA-TR				2 Assemblies		SEAM-50-01-L-10-2-RA-TR	
2 Assemblies		2 Assemblies		2 Assemblies		2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown ⁽²⁾	1.	DWV Breakdown ⁽²⁾	1.	DWV Breakdown ⁽²⁾	1.	IR ⁽⁴⁾
						2.	DWV at Test Voltage ⁽¹⁾
						3.	Thermal Shock ⁽⁵⁾
						4.	IR ⁽⁴⁾
						5.	DWV at Test Voltage ⁽¹⁾
						6.	Humidity ⁽³⁾
						7.	IR ⁽⁴⁾
						8.	DWV at Test Voltage ⁽¹⁾

- (1) DWV at Test Voltage = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (2) DWV Breakdown = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (3) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b
- (4) IR = EIA-364-21
Test Condition = 500 Vdc, 2 Minutes Max
- (5) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**Current Carrying Capacity****Group 1**

SEAF-50-01-L-10-2-RA-TR
SEAM-50-01-L-10-2-RA-TR
10 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 1

Group 2

SEAF-50-01-L-10-2-RA-TR
SEAM-50-01-L-10-2-RA-TR
20 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 2

Group 3

SEAF-50-01-L-10-2-RA-TR
SEAM-50-01-L-10-2-RA-TR
30 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 3

Group 4

SEAF-50-01-L-10-2-RA-TR
SEAM-50-01-L-10-2-RA-TR
40 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 4

Group 5

SEAF-50-01-L-10-2-RA-TR
SEAM-50-01-L-10-2-RA-TR
500 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 10
Number of Positions = 50

(1) CCC = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

FLOWCHARTS Continued**Mechanical Shock/Random Vibration/LLCR**Group 1

SEAF-50-01-L-10-2-RA-TR

SEAM-50-01-L-10-2-RA-TR

8 Assemblies

Step Description

1. LLCR ⁽¹⁾
2. Mechanical Shock ⁽²⁾
3. Random Vibration ⁽³⁾
4. LLCR ⁽¹⁾
Max Delta = 15 mOhm

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event DetectionGroup 1

SEAF-50-01-L-10-2-RA-TR

SEAM-50-01-L-10-2-RA-TR

60 Points

Step Description

1. Nanosecond Event Detection
(Mechanical Shock) ⁽¹⁾
2. Nanosecond Event Detection
(Random Vibration) ⁽²⁾

(1) Nanosecond Event Detection (Mechanical Shock)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-27 for Mechanical Shock:

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-28 for Random Vibration:

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL SHOCK:

- 1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors*.
- 2) Test Condition 1: -55°C to +85°C
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Number of Cycles: 100
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

THERMAL:

- 1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors*.
- 2) Test Condition 4 at 105° C.
- 3) Test Time Condition B for 250 hours.
- 4) All test samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition B, 240 Hours.
- 3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
- 2) Test Condition C
- 3) Peak Value: 100 G
- 4) Duration: 6 Milliseconds
- 5) Wave Form: Half Sine
- 6) Velocity: 12.3 ft/s
- 7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

- 1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
- 2) Test Condition V, Letter B
- 3) Power Spectral Density: 0.04 G² / Hz
- 4) G 'RMS': 7.56
- 5) Frequency: 50 to 2000 Hz
- 6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

- 1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
- 2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
- 3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

MATING/UNMATING:

- 1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
- 2) The full insertion position was to within 0.003" to 0.004" of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at four temperature points are reported:
 - a. Ambient
 - b. 85° C
 - c. 95° C
 - d. 115° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

GAS TIGHT:

To provide method for evaluating the ability of the contacting surfaces in preventing penetration of harsh vapors which might lead to oxide formation that may degrade the electrical performance of the contact system.

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure
- 4) Procedure:
 - a. Reference document: EIA-364-36, *Test Procedure for Determination of Gas-Tight Characteristics for Electrical Connectors, Sockets and/or Contact Systems*.
 - b. Test Conditions:
 - i. Class II--- Mated pairs of contacts assembled to their plastic housings.
 - ii. Reagent grade Nitric Acid shall be used of sufficient volume to saturate the test chamber
 - iii. The ratio of the volume of the test chamber to the surface area of the acid shall be 10:1.
 - iv. The chamber shall be saturated with the vapor for at least 15 minutes before samples are added.
 - v. Exposure time, 55 to 65 minutes.
 - vi. The samples shall be no closer to the chamber walls than 1 inches and no closer to the surface of the acid than 3 inches.
 - vii. The samples shall be dried after exposure for a minimum of 1 hour.
 - viii. Drying temperature 50°C
 - ix. The final LLCR shall be conducted within 1 hour after drying.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Electrification Time 2.0 minutes
 - iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
- 2) MEASUREMENTS:
- 3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 5000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Barometric Test Condition 1
 - iii. Rate of Application 500 V/Sec
 - iv. Test Voltage (VAC) until breakdown occurs
- 2) MEASUREMENTS/CALCULATIONS
 - a. The breakdown voltage shall be measured and recorded.
 - b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
 - c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

RESULTS

Temperature Rise, CCC at a 20% de-rating

- CCC for a 30°C Temperature Rise-----1.9 A per contact with 10 power contacts (10x1) powered
- CCC for a 30°C Temperature Rise-----1.3 A per contact with 20 power contacts (10x2) powered
- CCC for a 30°C Temperature Rise-----1.1 A per contact with 30 power contacts (10x3) powered
- CCC for a 30°C Temperature Rise-----0.9 A per contact with 40 power contacts (10x4) powered
- CCC for a 30°C Temperature Rise-----0.4 A per contact with 500 power contacts (10x50) powered

Mating/Unmating Forces: Thermal Aging Group

SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR

- Initial
 - Mating
 - Min -----19.52 Lbs
 - Max-----23.63 Lbs
 - Unmating
 - Min -----7.67 Lbs
 - Max-----14.36 Lbs
- After Thermal
 - Mating
 - Min -----14.54 Lbs
 - Max-----19.60 Lbs
 - Unmating
 - Min -----9.86 Lbs
 - Max-----11.66 Lbs

RESULTS Continued**Mating/Unmating Forces: Mating/Unmating Durability Group
SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR**

- **Initial**
 - **Mating**
 - Min -----17.96 Lbs
 - Max -----23.92 Lbs
 - **Unmating**
 - Min -----10.17 Lbs
 - Max -----13.94 Lbs
- **After 25 Cycles**
 - **Mating**
 - Min -----16.37 Lbs
 - Max -----22.00 Lbs
 - **Unmating**
 - Min -----10.60 Lbs
 - Max -----16.53 Lbs
- **After 50 Cycles**
 - **Mating**
 - Min -----16.26 Lbs
 - Max -----21.00 Lbs
 - **Unmating**
 - Min -----10.93 Lbs
 - Max -----16.65 Lbs
- **After 75 Cycles**
 - **Mating**
 - Min -----16.30 Lbs
 - Max -----21.02 Lbs
 - **Unmating**
 - Min -----11.34 Lbs
 - Max -----16.67 Lbs
- **After 100 Cycles**
 - **Mating**
 - Min -----16.42 Lbs
 - Max -----21.01 Lbs
 - **Unmating**
 - Min -----11.78 Lbs
 - Max -----16.94 Lbs
- **After Humidity**
 - **Mating**
 - Min -----16.17 Lbs
 - Max -----20.08 Lbs
 - **Unmating**
 - Min -----10.11 Lbs
 - Max -----12.10 Lbs

RESULTS Continued**Mating/Unmating Forces: Mating/Unmating Basic Group
SEAF-20-01-L-04-2-RA-TR/SEAM-20-01-L-04-2-RA-TR**

- **Initial**
 - **Mating**
 - **Min**-----3.31 Lbs
 - **Max**-----3.70 Lbs
 - **Unmating**
 - **Min**-----2.11 Lbs
 - **Max**-----2.75 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min**-----3.45 Lbs
 - **Max**-----3.96 Lbs
 - **Unmating**
 - **Min**-----2.38 Lbs
 - **Max**-----3.03 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min**-----3.43 Lbs
 - **Max**-----3.95 Lbs
 - **Unmating**
 - **Min**-----2.46 Lbs
 - **Max**-----3.12 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min**-----3.46 Lbs
 - **Max**-----3.94 Lbs
 - **Unmating**
 - **Min**-----2.57 Lbs
 - **Max**-----3.17 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min**-----3.42 Lbs
 - **Max**-----4.04 Lbs
 - **Unmating**
 - **Min**-----2.64 Lbs
 - **Max**-----3.21 Lbs

RESULTS Continued**Mating/Unmating Forces: Mating/Unmating Basic Group
SEAF-30-01-L-08-2-RA-TR/SEAM-30-01-L-08-2-RA-TR**

- **Initial**
 - **Mating**
 - **Min**-----9.02 Lbs
 - **Max**-----10.87 Lbs
 - **Unmating**
 - **Min**-----6.25 Lbs
 - **Max**-----8.58 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min**-----9.79 Lbs
 - **Max**-----11.80 Lbs
 - **Unmating**
 - **Min**-----7.21 Lbs
 - **Max**-----8.85 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min**-----9.20 Lbs
 - **Max**-----10.84 Lbs
 - **Unmating**
 - **Min**-----7.20 Lbs
 - **Max**-----8.39 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min**-----9.28 Lbs
 - **Max**-----10.87 Lbs
 - **Unmating**
 - **Min**-----7.28 Lbs
 - **Max**-----8.52 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min**-----9.33 Lbs
 - **Max**-----10.69 Lbs
 - **Unmating**
 - **Min**-----7.60 Lbs
 - **Max**-----8.84 Lbs

RESULTS Continued**Insulation Resistance minimums, IR****Pin to Pin**

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
 - Unmated -----45000 Meg Ω ----- Passed
- **Thermal**
 - Mated-----45000 Meg Ω ----- Passed
 - Unmated -----45000 Meg Ω ----- Passed
- **Humidity**
 - Mated----- 8000 Meg Ω ----- Passed
 - Unmated -----10700 Meg Ω ----- Passed

Row to Row

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
 - Unmated -----45000 Meg Ω ----- Passed
- **Thermal**
 - Mated-----45000 Meg Ω ----- Passed
 - Unmated -----45000 Meg Ω ----- Passed
- **Humidity**
 - Mated----- 7000 Meg Ω ----- Passed
 - Unmated ----- 6600 Meg Ω ----- Passed

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
 - Breakdown Voltage----- 1174 VAC
 - Test Voltage -----881 VAC
 - Working Voltage -----290 VAC

Pin to Pin

- **Initial DWV**-----Passed
- **Thermal DWV**-----Passed
- **Humidity DWV**-----Passed

Row to Row

- **Initial DWV**-----Passed
- **Thermal DWV**-----Passed
- **Humidity DWV**-----Passed

RESULTS Continued**LLCR Gas Tight (192 LLCR test points)****Row 1**

- **Initial** ----- 10.74 mOhms Max
- **Gas-Tight**
 - <= +5.0 mOhms ----- 40 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 2

- **Initial** ----- 14.06 mOhms Max
- **Gas-Tight**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 3

- **Initial** ----- 17.47 mOhms Max
- **Gas-Tight**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 4

- **Initial** ----- 25.22 mOhms Max
- **Gas-Tight**
 - <= +5.0 mOhms ----- 56 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

RESULTS Continued**LLCR Thermal Aging (192 LLCR test points)****Row 1**

- **Initial** ----- 10.71 mOhms Max
- **Thermal Aging**
 - <= +5.0 mOhms ----- 40 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 2

- **Initial** ----- 14.39 mOhms Max
- **Thermal Aging**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 3

- **Initial** ----- 20.15 mOhms Max
- **Thermal Aging**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 4

- **Initial** ----- 25.57 mOhms Max
- **Thermal Aging**
 - <= +5.0 mOhms ----- 56 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

RESULTS Continued**LLCR Durability (192 LLCR test points)****Row 1**

- **Initial** ----- 10.21 mOhms Max
- **Durability, 100 Cycles**
 - **<= +5.0 mOhms** ----- 40 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Thermal**
 - **<= +5.0 mOhms** ----- 40 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Humidity**
 - **<= +5.0 mOhms** ----- 40 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure

Row 2

- **Initial** ----- 14.36 mOhms Max
- **Durability, 100 Cycles**
 - **<= +5.0 mOhms** ----- 48 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Thermal**
 - **<= +5.0 mOhms** ----- 48 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Humidity**
 - **<= +5.0 mOhms** ----- 48 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure

RESULTS Continued**Row 3**

- **Initial**----- 18.41 mOhms Max
- **Durability, 100 Cycles**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Thermal**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Humidity**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 4

- **Initial**----- 25.75 mOhms Max
- **Durability, 100 Cycles**
 - <= +5.0 mOhms ----- 56 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Thermal**
 - <= +5.0 mOhms ----- 56 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Humidity**
 - <= +5.0 mOhms ----- 56 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

RESULTS Continued**LLCR Shock & Vibration (192 LLCR test points)****Row 1**

- **Initial** ----- 10.79 mOhms Max
- **Shock & Vibration**
 - <= +5.0 mOhms ----- 40 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 2

- **Initial** ----- 13.93 mOhms Max
- **Shock & Vibration**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 3

- **Initial** ----- 17.67 mOhms Max
- **Shock & Vibration**
 - <= +5.0 mOhms ----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Row 4

- **Initial** ----- 25.82 mOhms Max
- **Shock & Vibration**
 - <= +5.0 mOhms ----- 56 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

Mechanical Shock & Random Vibration:

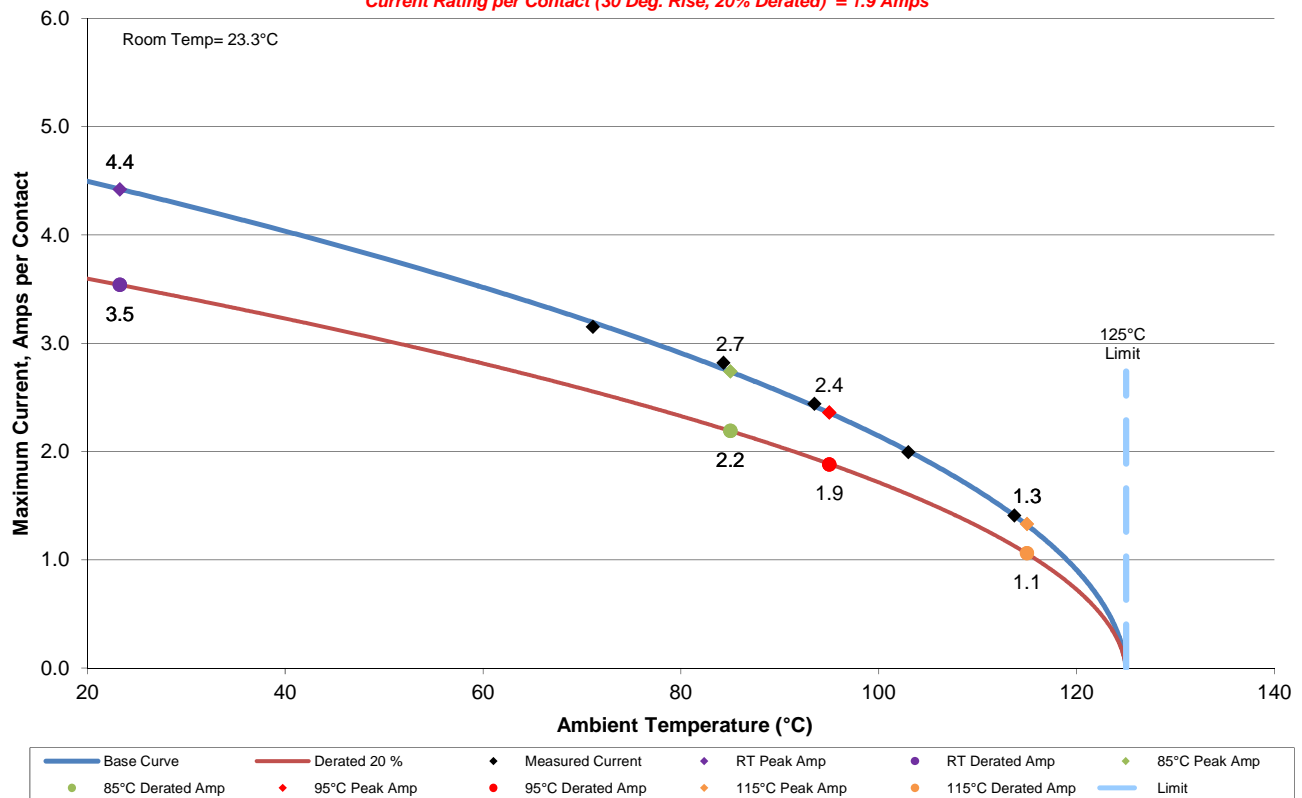
- **Shock**
 - **No Damage**----- Pass
 - **50 Nanoseconds**----- Pass
- **Vibration**
 - **No Damage**----- Pass
 - **50 Nanoseconds**----- Pass

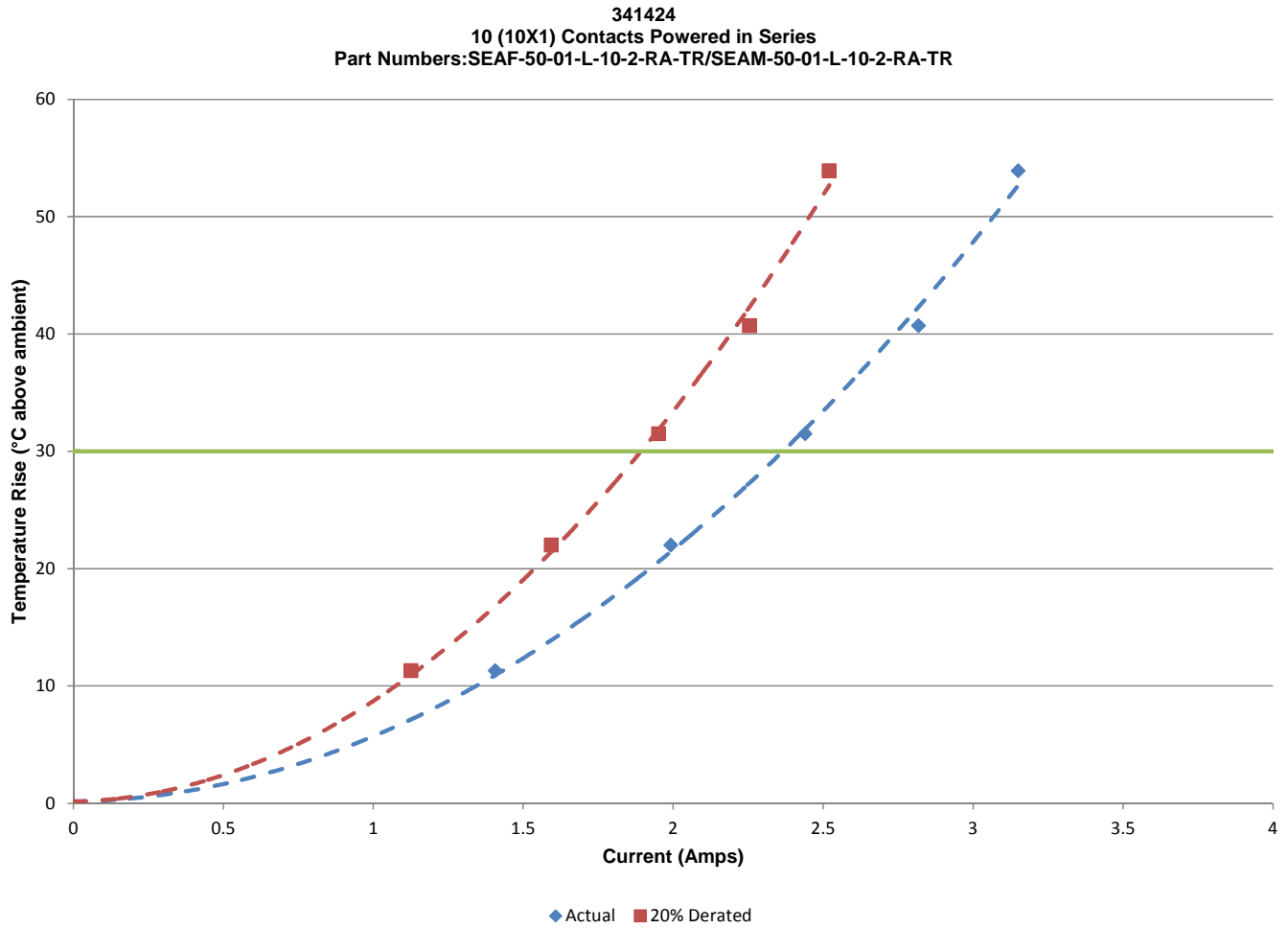
DATA SUMMARIES**TEMPERATURE RISE (Current Carrying Capacity, CCC):**

- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
- 4) Adjacent contacts were powered:
 - a. Linear configuration with 10 adjacent conductors/contacts powered

341424
10 (10X1) Contacts Powered in Series
Part Numbers:SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR

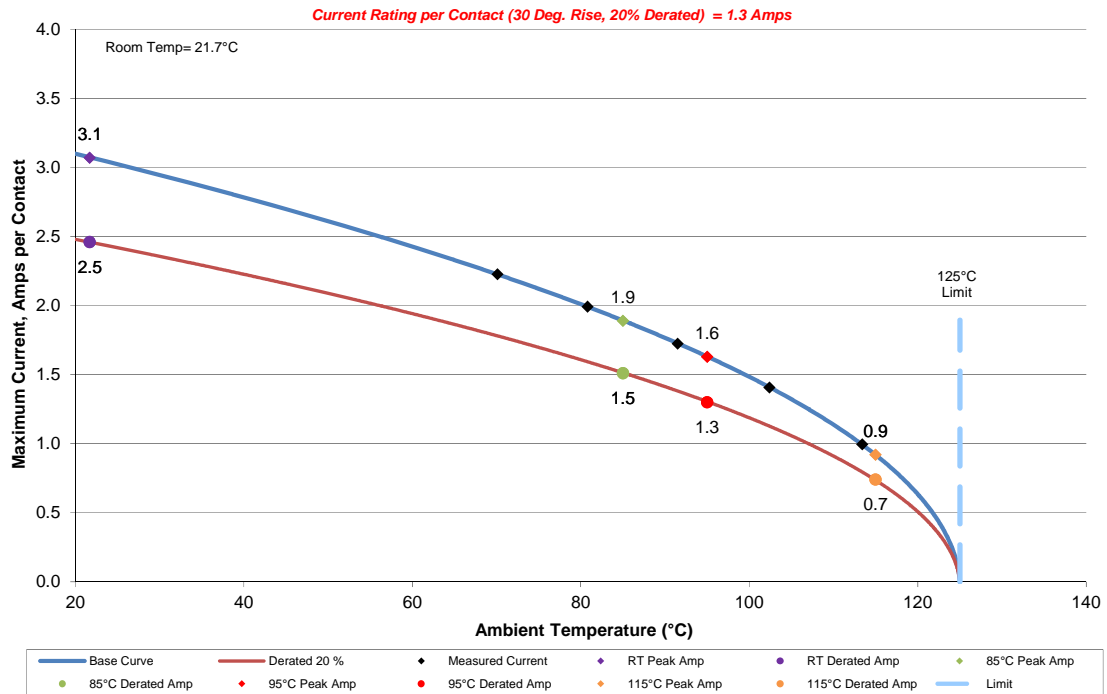
Current Rating per Contact (30 Deg. Rise, 20% Derated) = 1.9 Amps



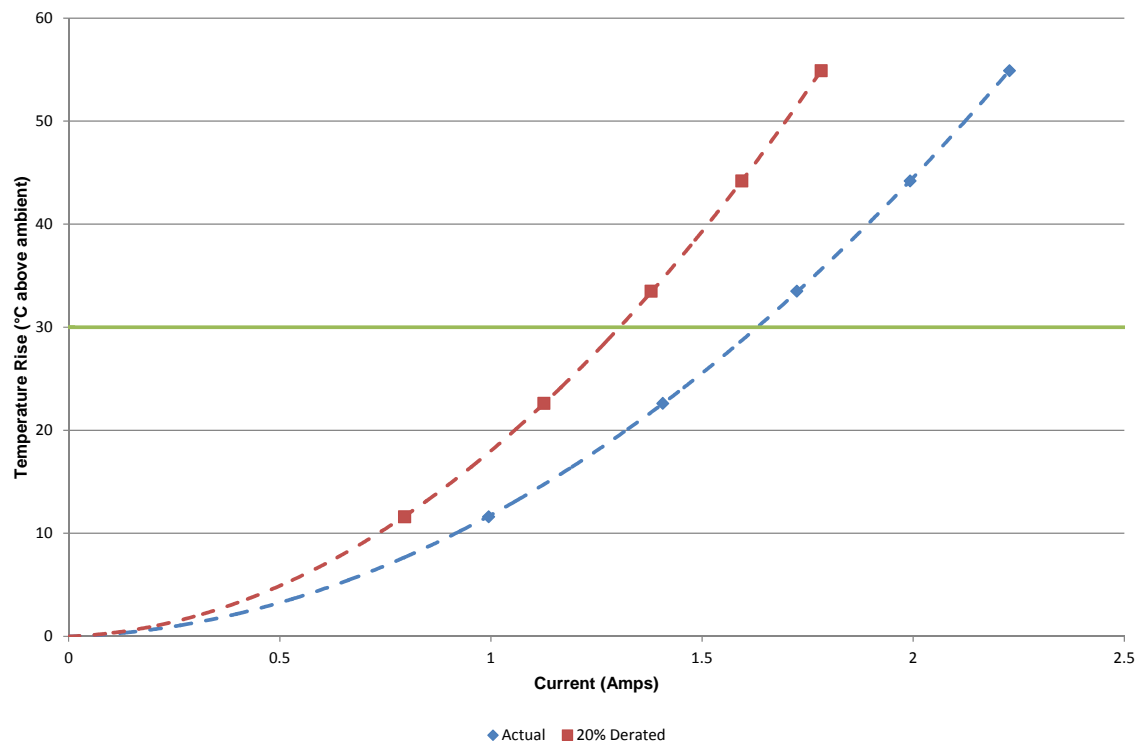


DATA SUMMARIES Continued**b. Linear configuration with 20 adjacent conductors/contacts powered**

341424
20 (10X2) Contacts Powered in Series
Part Numbers:SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR



341424
20 (10X2) Contacts Powered in Series
Part Numbers:SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR

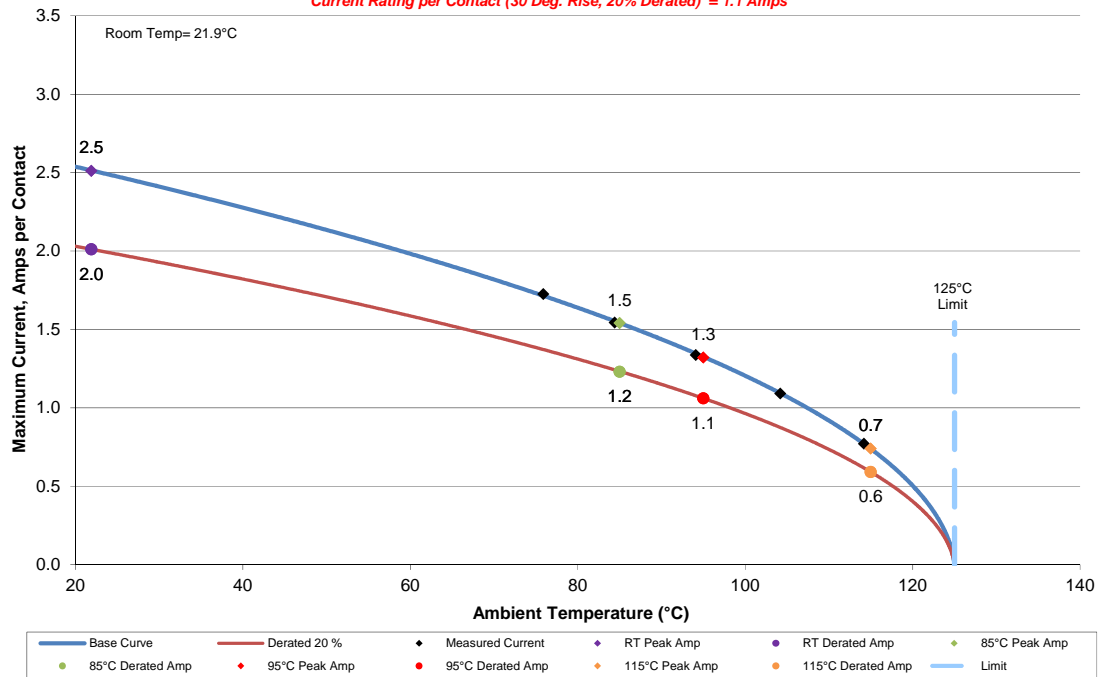


DATA SUMMARIES Continued**c. Linear configuration with 30 adjacent conductors/contacts powered**

341424

30 (10X3) Contacts Powered in Series

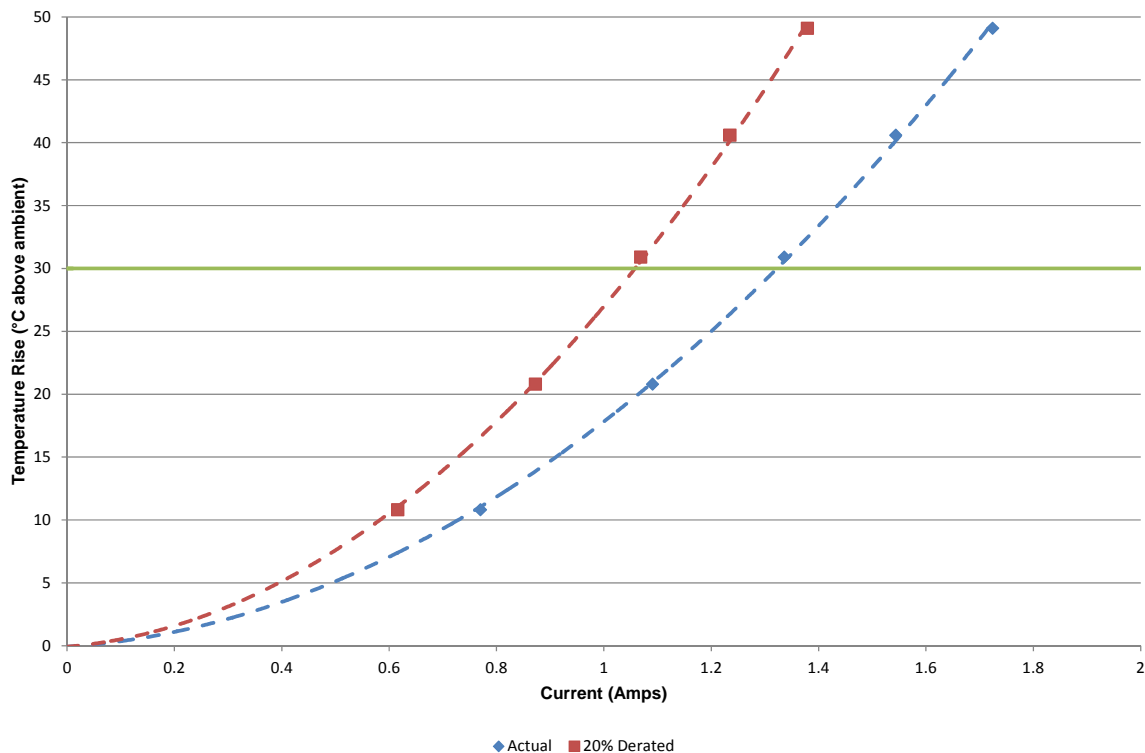
Part Numbers:SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 1.1 Amps

341424

30 (10X3) Contacts Powered in Series

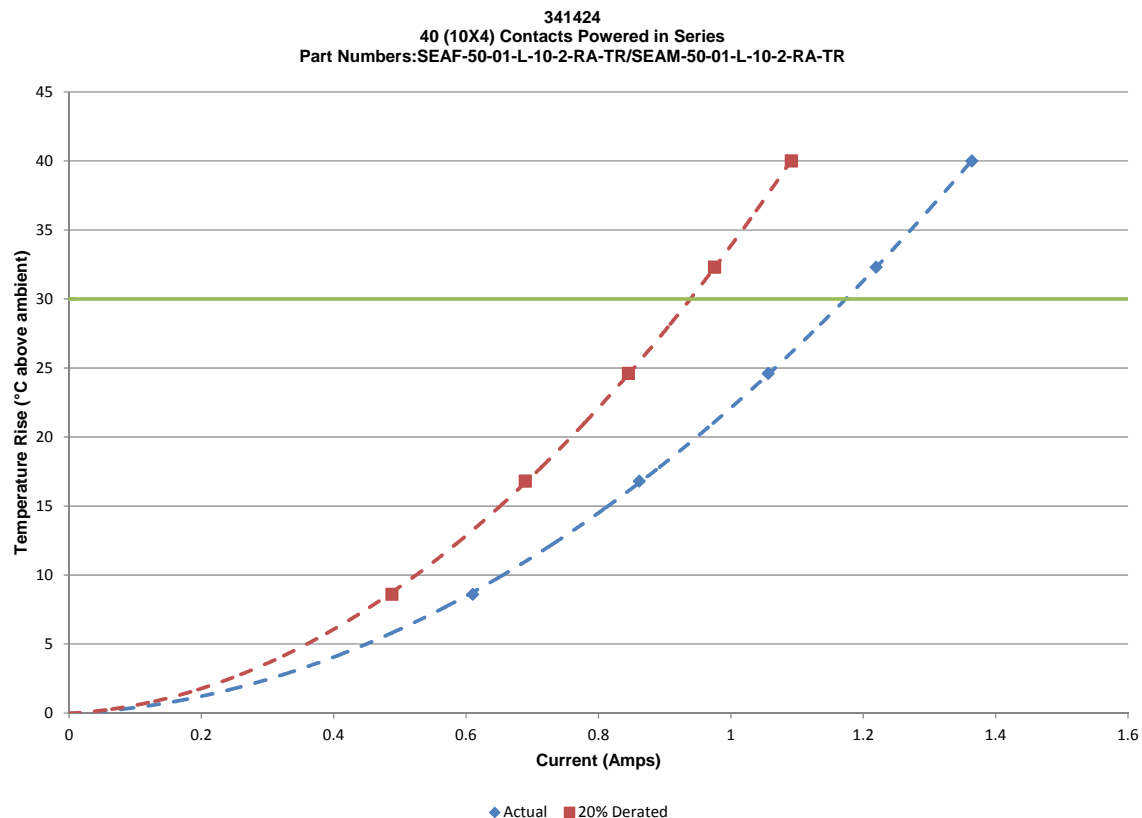
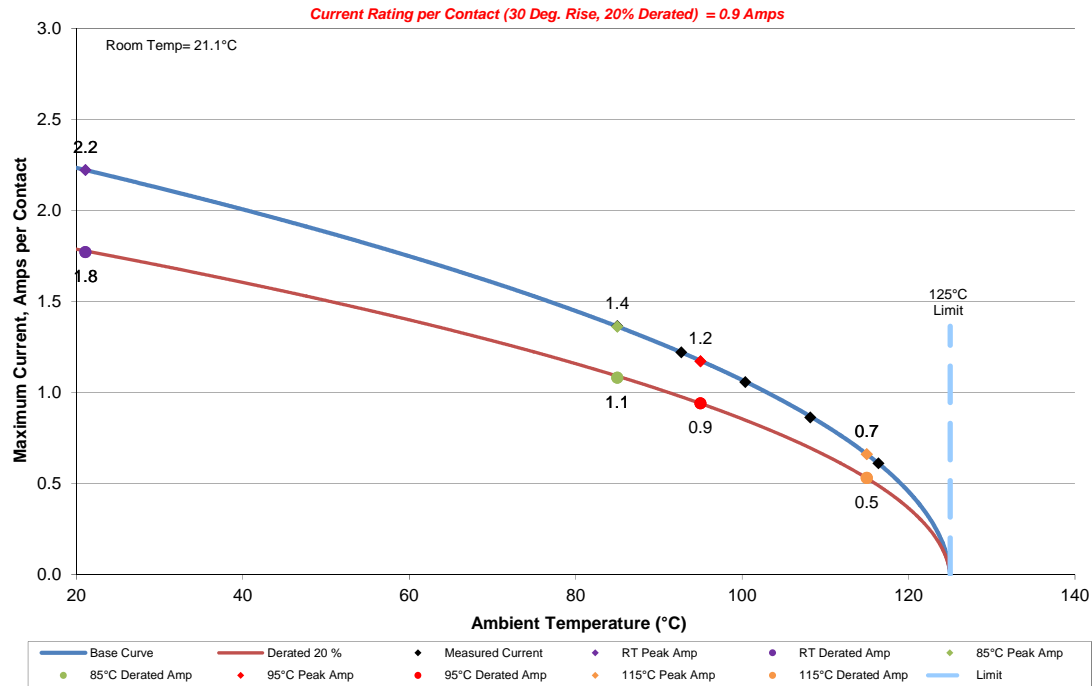
Part Numbers:SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR



DATA SUMMARIES Continued

d. Linear configuration with 40 adjacent conductors/contacts powered

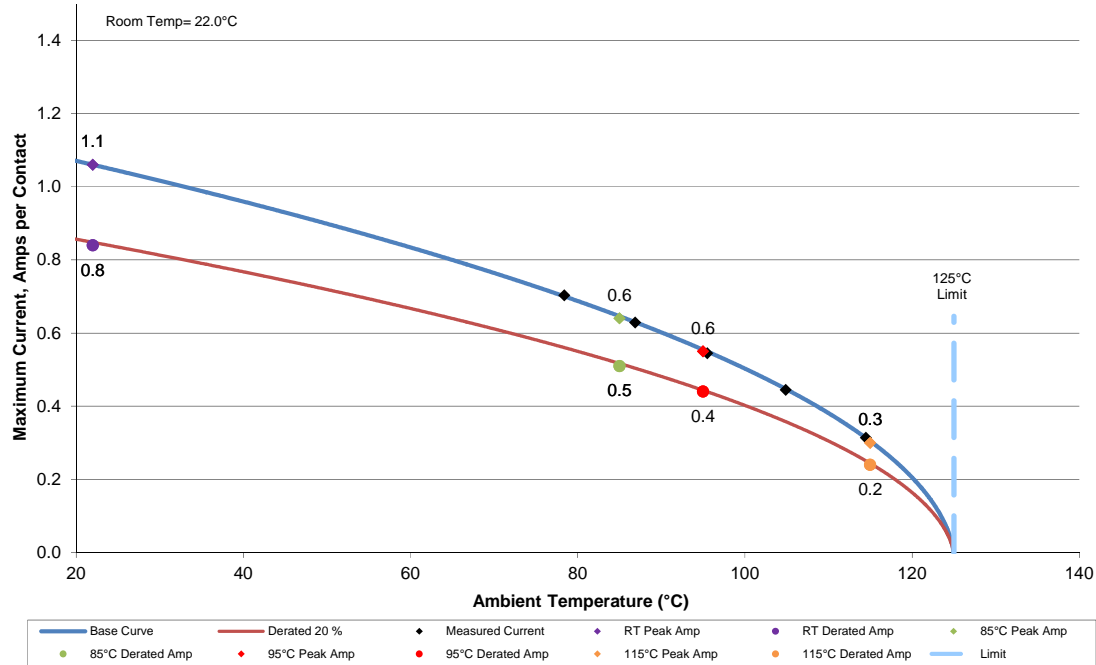
341424
40 (10X4) Contacts Powered in Series
Part Numbers:SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR



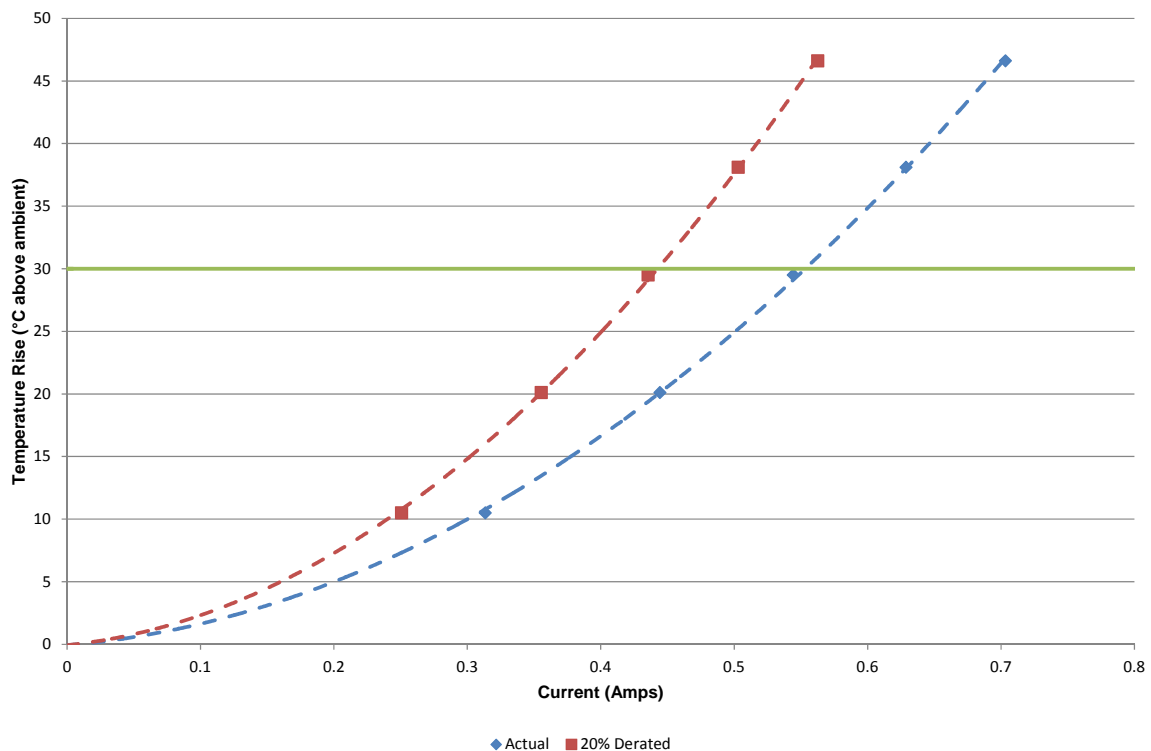
DATA SUMMARIES Continued

e. Linear configuration with all adjacent conductors/contacts powered

341424
500 (All Power) Contacts Powered in Series
Part Numbers:SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 0.4 Amps

341424
500 (All Power) Contacts Powered in Series
Part Numbers:SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR



DATA SUMMARIES Continued**Mating\Unmating Force: Thermal Aging Group**
SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR

	Initial				After Thermals			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	86.82	19.52	34.12	7.67	64.67	14.54	43.86	9.86
Maximum	105.11	23.63	63.87	14.36	87.18	19.60	51.86	11.66
Average	93.81	21.09	53.59	12.05	73.61	16.55	47.02	10.57
St Dev	6.75	1.52	9.28	2.09	6.25	1.40	2.95	0.66
Count	8	8	8	8	8	8	8	8

Mating\Unmating Force: Mating\Unmating Durability Group
SEAF-50-01-L-10-2-RA-TR/SEAM-50-01-L-10-2-RA-TR

	Initial				25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	79.89	17.96	45.24	10.17	72.81	16.37	47.15	10.60
Maximum	106.40	23.92	62.01	13.94	97.86	22.00	73.53	16.53
Average	92.38	20.77	52.80	11.87	84.69	19.04	56.78	12.77
St Dev	10.88	2.45	6.32	1.42	9.32	2.10	8.89	2.00
Count	8	8	8	8	8	8	8	8

	50 Cycles				75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	72.32	16.26	48.62	10.93	72.50	16.30	50.44	11.34
Maximum	93.41	21.00	74.06	16.65	93.50	21.02	74.15	16.67
Average	82.66	18.58	59.17	13.30	82.40	18.53	60.59	13.62
St Dev	7.69	1.73	8.60	1.93	7.47	1.68	8.28	1.86
Count	8	8	8	8	8	8	8	8

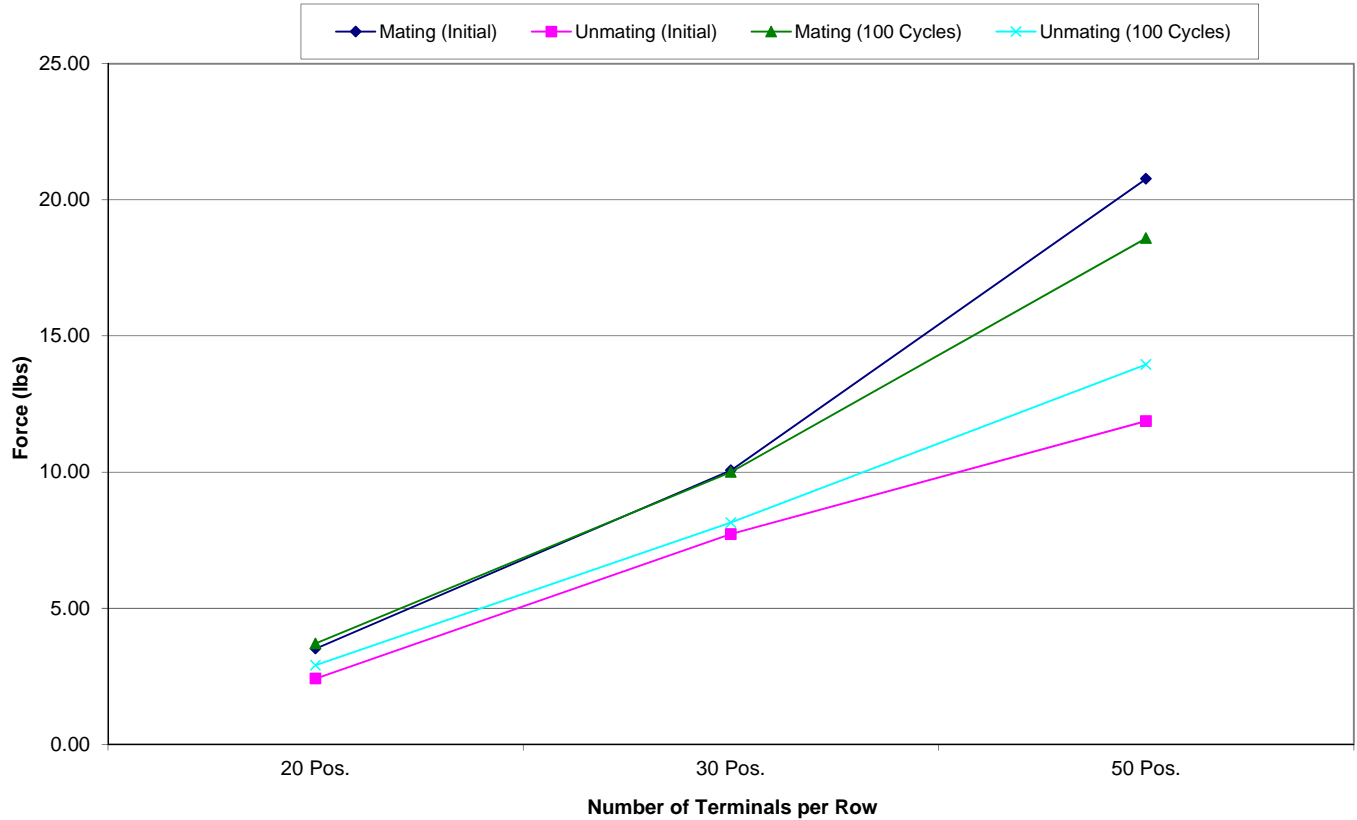
	100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	73.04	16.42	52.40	11.78	71.92	16.17	44.97	10.11
Maximum	93.45	21.01	75.35	16.94	89.32	20.08	53.82	12.10
Average	82.67	18.59	62.06	13.95	80.35	18.07	49.85	11.21
St Dev	7.35	1.65	8.01	1.80	7.10	1.60	3.33	0.75
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**Mating\Unmating Force: Mating\Unmating Basic Group
SEAF-20-01-L-04-2-RA-TR/SEAM-20-01-L-04-2-RA-TR**

	Initial				25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)
Minimum	14.72	3.31	9.39	2.11	15.35	3.45	10.59	2.38
Maximum	16.46	3.70	12.23	2.75	17.61	3.96	13.48	3.03
Average	15.62	3.51	10.71	2.41	16.47	3.70	11.94	2.68
St Dev	0.59	0.13	0.85	0.19	0.79	0.18	1.01	0.23
Count	8	8	8	8	8	8	8	8
	50 Cycles				75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)
Minimum	15.26	3.43	10.94	2.46	15.39	3.46	11.43	2.57
Maximum	17.57	3.95	13.88	3.12	17.53	3.94	14.10	3.17
Average	16.19	3.64	12.15	2.73	16.22	3.65	12.59	2.83
St Dev	0.81	0.18	0.88	0.20	0.88	0.20	0.92	0.21
Count	8	8	8	8	8	8	8	8
	100 Cycles							
	Mating		Unmating					
	Newton	Force (Lbs)	Newton	Force (Lbs)				
Minimum	15.21	3.42	11.74	2.64				
Maximum	17.97	4.04	14.28	3.21				
Average	16.47	3.70	12.92	2.90				
St Dev	0.97	0.22	0.80	0.18				
Count	8	8	8	8				

DATA SUMMARIES Continued**Mating\Unmating Force: Mating\Unmating Basic Group
SEAF-30-01-L-08-2-RA-TR/SEAM-30-01-L-08-2-RA-TR**

	Initial				25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	40.12	9.02	27.80	6.25	43.55	9.79	32.07	7.21
Maximum	48.35	10.87	38.16	8.58	52.49	11.80	39.36	8.85
Average	44.75	10.06	34.33	7.72	48.72	10.95	35.70	8.03
St Dev	2.63	0.59	3.16	0.71	2.81	0.63	2.28	0.51
Count	8	8	8	8	8	8	8	8
	50 Cycles				75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	40.92	9.20	32.03	7.20	41.28	9.28	32.38	7.28
Maximum	48.22	10.84	37.32	8.39	48.35	10.87	37.90	8.52
Average	45.09	10.14	34.65	7.79	44.65	10.04	35.33	7.94
St Dev	2.42	0.54	1.89	0.42	2.38	0.53	1.94	0.44
Count	8	8	8	8	8	8	8	8
	100 Cycles							
	Mating		Unmating					
	Newtons	Force (Lbs)	Newtons	Force (Lbs)				
Minimum	41.50	9.33	33.80	7.60				
Maximum	47.55	10.69	39.32	8.84				
Average	44.47	10.00	36.20	8.14				
St Dev	2.12	0.48	1.92	0.43				
Count	8	8	8	8				

DATA SUMMARIES Continued**Mating\Unmating Force Comparison****Mating/Unmating Data for 20, 30 and 50 Position SEAF/SEAM**

DATA SUMMARIES Continued**INSULATION RESISTANCE (IR):**

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	SEAF/SEAM	SEAF	SEAM
Initial	45000	45000	45000
Thermal	45000	45000	45000
Humidity	8000	44000	10700

	Row to Row		
	Mated	Unmated	Unmated
Minimum	SEAF/SEAM	SEAF	SEAM
Initial	45000	45000	45000
Thermal	45000	45000	45000
Humidity	7000	21600	6600

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	SEAF/SEAM
Break Down Voltage	1174
Test Voltage	881
Working Voltage	290

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued**LLCR Durability:**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms:----- Stable
 - b. $+5.1$ to $+10.0$ mOhms:----- Minor
 - c. $+10.1$ to $+15.0$ mOhms:----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:----- Marginal
 - e. $+50.1$ to $+2000$ mOhms----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2014/9/4	2014/9/16	2014/9/23	2014/10/3
Room Temp (Deg C)	21	22	22	22
Rel Humidity (%)	50	39	43	43
Technician	Aaron McKim	Aaron McKim	Aaron McKim	Aaron McKim
mOhm values	Actual Initial	Delta 100 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Row 1				
Average	9.49	0.33	0.39	0.75
St. Dev.	0.49	0.34	0.40	0.45
Min	8.61	0.00	0.00	0.03
Max	10.21	1.48	1.54	1.98
Summary Count	40	40	40	40
Total Count	40	40	40	40
Pin Type 2: Row 2				
Average	13.17	0.29	0.35	0.66
St. Dev.	0.52	0.26	0.31	0.31
Min	12.10	0.00	0.01	0.18
Max	14.36	1.15	1.24	1.27
Summary Count	48	48	48	48
Total Count	48	48	48	48
Pin Type 3: Row 3				
Average	16.80	0.30	0.32	0.69
St. Dev.	0.52	0.28	0.34	0.39
Min	15.67	0.00	0.00	0.16
Max	18.41	1.16	1.69	1.54
Summary Count	48	48	48	48
Total Count	48	48	48	48
Pin Type 4: Row 4				
Average	22.57	0.24	0.24	0.57
St. Dev.	2.26	0.17	0.23	0.49
Min	19.13	0.00	0.01	0.10
Max	25.75	0.71	1.03	3.52
Summary Count	56	56	56	56
Total Count	56	56	56	56

<i>LLCR Delta Count by Category</i>						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
100 Cycles	192	0	0	0	0	0
Therm Shck	192	0	0	0	0	0
Humidity	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Thermal Aging:**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2014/9/9	2014/9/22		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	40	37		
Technician	Aaron McKim	Aaron McKim		
mOhm values	Actual Initial	Delta Thermal	Delta	Delta
Pin Type 1: Row 1				
Average	9.52	0.45		
St. Dev.	0.68	0.39		
Min	8.25	0.01		
Max	10.71	1.51		
Summary Count	40	40		
Total Count	40	40		
Pin Type 2: Row 2				
Average	13.15	0.36		
St. Dev.	0.68	0.45		
Min	12.09	0.00		
Max	14.39	2.39		
Summary Count	48	48		
Total Count	48	48		
Pin Type 3: Row 3				
Average	16.69	0.28		
St. Dev.	0.81	0.35		
Min	15.62	0.01		
Max	20.15	2.29		
Summary Count	48	48		
Total Count	48	48		
Pin Type 4: Row 4				
Average	22.51	0.27		
St. Dev.	2.37	0.23		
Min	18.82	0.01		
Max	25.57	1.16		
Summary Count	56	56		
Total Count	56	56		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
Thermal	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Gas Tight:**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2014/8/19	2014/8/19		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	48	47		
Technician	Tony Wagoner	Tony Wagoner		
mOhm values	Actual Initial	Delta Acid Vapor	Delta	Delta
Pin Type 1: Row 1				
Average	9.31	0.31		
St. Dev.	0.73	0.22		
Min	8.38	0.01		
Max	10.74	1.32		
Summary Count	40	40		
Total Count	40	40		
Pin Type 2: Row 2				
Average	12.97	0.51		
St. Dev.	0.68	0.11		
Min	11.95	0.28		
Max	14.06	0.96		
Summary Count	48	48		
Total Count	48	48		
Pin Type 3: Row 3				
Average	16.60	0.56		
St. Dev.	0.70	0.09		
Min	15.51	0.32		
Max	17.47	0.75		
Summary Count	48	48		
Total Count	48	48		
Pin Type 4: Row 4				
Average	22.32	0.73		
St. Dev.	2.36	0.09		
Min	19.02	0.50		
Max	25.22	0.91		
Summary Count	56	56		
Total Count	56	56		

LLCR Delta Count by Category

	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
Acid Vapor	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Shock & Vibration:**

- 1). A total of 192 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2014/10/1	2014/12/5		
Room Temp (Deg C)	21	21		
Rel Humidity (%)	44	37		
Technician	Aaron McKim	Aaron McKim		
mOhm values	Actual Initial	Delta Shock-Vib	Delta	Delta
Pin Type 1: Row 1				
Average	9.32	0.24		
St. Dev.	0.74	0.29		
Min	7.91	0.00		
Max	10.79	1.35		
Summary Count	40	40		
Total Count	40	40		
Pin Type 2: Row 2				
Average	13.03	0.20		
St. Dev.	0.61	0.18		
Min	11.74	0.00		
Max	13.93	1.08		
Summary Count	48	48		
Total Count	48	48		
Pin Type 3: Row 3				
Average	16.69	0.20		
St. Dev.	0.60	0.22		
Min	15.67	0.01		
Max	17.67	1.14		
Summary Count	48	48		
Total Count	48	48		
Pin Type 4: Row 4				
Average	22.57	0.24		
St. Dev.	2.29	0.22		
Min	19.10	0.02		
Max	25.82	1.12		
Summary Count	56	56		
Total Count	56	56		

LLCR Delta Count by Category

	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
Shock-Vib	192	0	0	0	0	0

Nanosecond Event Detection:**Shock and Vibration Event Detection Summary**

Contacts tested	60
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** TCT-07**Description:** Automated Test Stand**Manufacturer:** Chatillon/Lloyd**Model:** LF Plus**Serial #:** LF1310**Accuracy:** See Manual

... Last Cal: 11/14/2014, Next Cal: 11/14/2015

Equipment #: HPT-01**Description:** Hipot Safety Tester**Manufacturer:** Vitrek**Model:** V73**Serial #:** 019808**Accuracy:**

... Last Cal: 05/15/2014, Next Cal: 05/15/2015

Equipment #: MO-04**Description:** Multimeter /Data Acquisition System**Manufacturer:** Keithley**Model:** 2700**Serial #:** 0798688**Accuracy:** See Manual

... Last Cal: 09/11/2014, Next Cal: 09/11/2015

Equipment #: PS-02**Description:** Power Supply**Manufacturer:** Hewlett-Packard**Model:** 6033A**Serial #:** N/A**Accuracy:** See Manual

... Last Cal: NOT CALIBRATED

Equipment #: MO-11**Description:** Switch/Multimeter**Manufacturer:** Keithley**Model:** 3706**Serial #:** 120169**Accuracy:** See Manual

... Last Cal: 09/11/2014, Next Cal: 09/11/2015

Equipment #: THC-05**Description:** Temperature/Humidity Chamber (Chamber Room)**Manufacturer:** Thermotron**Model:** SM-8-3800**Serial #:** 05 23 00 02**Accuracy:** See Manual

... Last Cal: 11/14/2014, Next Cal: 05/31/2015

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** TSC-01**Description:** Vertical Thermal Shock Chamber**Manufacturer:** Cincinnati Sub Zero**Model:** VTS-3-6-6-SC/AC**Serial #:** 10-VT14993**Accuracy:** See Manual

... Last Cal: 06/30/2014, Next Cal: 06/30/2015

Equipment #: OV-05**Description:** Forced Air Oven, 5 Cu. Ft., 120 V (Chamber Room)**Manufacturer:** Sheldon Mfg.**Model:** CE5F**Serial #:** 02008008**Accuracy:** +/- 5 deg. C

... Last Cal: 02/18/2014, Next Cal: 02/18/2015

Equipment #: SVC-01**Description:** Shock & Vibration Table**Manufacturer:** Data Physics**Model:** LE-DSA-10-20K**Serial #:** 10037**Accuracy:** See Manual

... Last Cal: 04/22/2014, Next Cal: 04/22/2015

Equipment #: ACLM-01**Description:** Accelerometer**Manufacturer:** PCB Piezotronics**Model:** 352C03**Serial #:** 115819**Accuracy:** See Manual

... Last Cal: 07/18/2014, Next Cal: 07/18/2015

Equipment #: ED-03**Description:** Event Detector**Manufacturer:** Analysis Tech**Model:** 32EHD**Serial #:** 1100604**Accuracy:** See Manual

... Last Cal: 10/31/2014, Next Cal: 10/31/2015